



**12500 TI Boulevard, MS 8640, Dallas, Texas 75243**

**PCN#20200629000.1**

**Qualification of new Fab site (RFAB) using qualified Process Technology, Die Revision, and additional Assembly site/BOM options for select devices**

**Change Notification / Sample Request**

**Date:** July 06, 2020

Dear TI Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

The customer should acknowledge receipt of this notification by email within **30** days of the date of receipt. Lack of acknowledgement of this notice within 30 days constitutes customer acceptance of the change.

Samples or additional data to support customer evaluation must be requested within 30 days of receipt of this notification. If samples are requested for evaluation the customer must provide evaluation results within the sample evaluation period indicated on page 3 of this notification. The Sample Evaluation Period begins on the date the customer receives samples from TI.

If the customer approved the change TI can proceed with implementation of the change. The proposed first ship date is shown on page 3.

If the customer does not approve the PCN or the approval response is not provided within the Sample Evaluation Period, TI can implement the change, but the customer may elect to place an order for unchanged product by the Last Time Buy Date for delivery by the Last Time Ship Date. TI cannot guarantee that shipments to the customer after any last time order is delivered will not include the changed material. If the customer places an order with delivery after the Last Time Shipment Date, the order may be fulfilled with changed material or any material processed to TI specifications at that future time.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Team ([PCN ww admin team@list.ti.com](mailto:PCN_admin_team@list.ti.com)). For sample requests or sample related questions, contact your field sales representative.

Sincerely,  
PCN Team  
SC Business Services

**20200629000.1**  
**Attachment: 1**

**Products Affected:**

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

<b>DEVICE</b>	<b>CUSTOMER PART NUMBER</b>
SN74HC14DR	36020090
SN74HC04DR	36020117
SN74HC32DR	36020144
SN74HC125DR	36020157
SN74HC74DR	36020172
SN74HC08DR	36020227

Technical details of this Product Change follow on the next page(s).

<b>PCN Number:</b>	20200629000.1		<b>PCN Date:</b>	July 6 2020
<b>Title:</b>	Qualification of new Fab site (RFAB) using qualified Process Technology, Die Revision, and additional Assembly site/BOM options for select devices			
<b>Customer Contact:</b>	<a href="#">PCN Manager</a>		<b>Dept:</b>	Quality Services
<b>Proposed 1<sup>st</sup> Ship Date:</b>	Oct 6 2020	<b>Sample Eval Period:</b>	180	
<b>Last Time Buy Date:</b>	Dec 6 2020	<b>Last Time Ship Date:</b>	Mar 6 2021	
<b>Change Type:</b>				
<input checked="" type="checkbox"/> Assembly Site	<input checked="" type="checkbox"/> Assembly Process	<input checked="" type="checkbox"/> Assembly Materials		
<input checked="" type="checkbox"/> Design	<input type="checkbox"/> Electrical Specification	<input type="checkbox"/> Mechanical Specification		
<input type="checkbox"/> Test Site	<input type="checkbox"/> Packing/Shipping/Labeling	<input type="checkbox"/> Test Process		
<input type="checkbox"/> Wafer Bump Site	<input type="checkbox"/> Wafer Bump Material	<input type="checkbox"/> Wafer Bump Process		
<input checked="" type="checkbox"/> Wafer Fab Site	<input checked="" type="checkbox"/> Wafer Fab Materials	<input checked="" type="checkbox"/> Wafer Fab Process		
	<input type="checkbox"/> Part number change			

### PCN Details

#### Description of Change:

Texas Instruments is pleased to announce the qualification of a new fab & process technology (RFAB, LBC9) and assembly (HFTAT) site/BOM (MLA) options for selected devices as listed below in the product affected section. Construction differences are noted below:

Current Fab Site			Additional Fab Site		
Current Fab Site	Process	Wafer Diameter	Additional Fab Site	Process	Wafer Diameter
SFAB	HCMOS	150 mm	RFAB	LBC9	300 mm

The die was also changed as a result of the process change.

Construction differences are noted below:

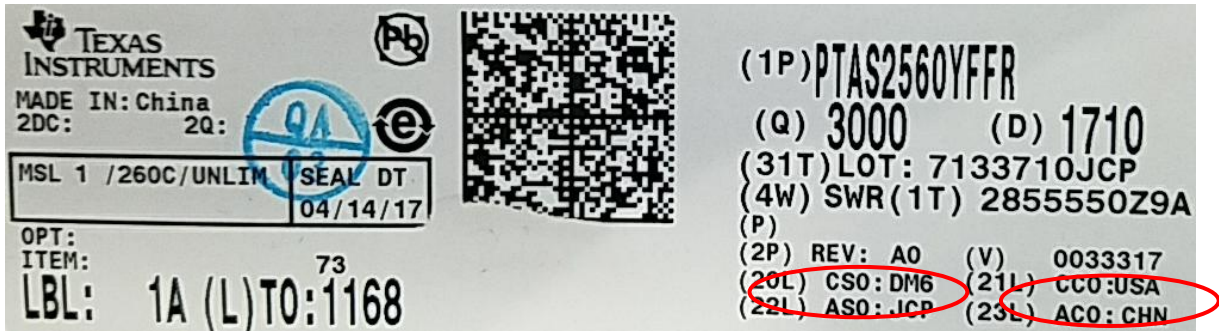
	ASESH	FMX	MLA Current	MLA New	HFTF
Mount Compound	SID#EY1000063	4147858	4147858	same	SID# A-03
Mold Compound	SID#EN2000511	4211880	4211880	same	SID#R-30
Lead finish	Matte Sn, non RLF	NiPdAu, non RLF	NiPdAu, non RLF	NiPdAu, RLF	Matte Sn, non RLF
Bond wire diameter (Cu)	0.8 mils	0.96 or 0.8mil	0.96 mils	0.8 mils	0.8 mils

Note: D Devices are currently built at one or more of the following AT sites: ASESH, FMX, MLA.

Upon expiry of this PCN TI will combine lead free solutions in a single [standard part number](#), for the devices in groups 1 & 2. For example; [CD74HC08PWR](#) – can ship with both Matte Sn and NiPdAu/Ag.

Example:

- Customer order for 7500 units of CD74HC08PWR with 2500 units SPQ (Standard Pack Quantity per Reel).
- TI can satisfy the above order in one of the following ways.
  - I. 3 Reels of NiPdAu finish.
  - II. 3 Reels of Matte Sn finish
  - III. 2 Reels of Matte Sn and 1 reel of NiPdAu finish.
  - IV. 2 Reels of NiPdAu and 1 reel of Matte Sn finish.

<b>Reason for Change:</b>			
SFAB Closure & Continuity of Supply			
<b>Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):</b>			
None			
<b>Anticipated impact on Material Declaration</b>			
<input type="checkbox"/>	No Impact to the Material Declaration	<input checked="" type="checkbox"/>	Material Declarations or Product Content reports are driven from production data and will be available following the production release. Upon production release the revised reports can be obtained from the <a href="#">TI ECO website</a> .
<b>Changes to product identification resulting from this PCN:</b>			
<b>Fab Site Information:</b>			
Chip Site	Chip Site Origin Code (20L)	Chip Site Country Code (21L)	Chip Site City
SH-BIP-1	SHE	USA	Sherman
<b>RFAB</b>	<b>RFB</b>	<b>USA</b>	<b>Richardson</b>
<b>Die Rev:</b>			
<b>Current</b>		<b>New</b>	
Die Rev [2P]	<b>Die Rev [2P]</b>		
E, G, K, or T	<b>B</b>		
<b>Assembly Site Information:</b>			
Assembly Site	Assembly Site Origin (22L)	Assembly Country Code (23L)	Assembly City
MLA	MLA	MYS	Kuala Lumpur
FMX	MEX	MEX	Aguascalientes
ASESH	ASH	CHN	Shanghai
<b>HFTFAT</b>	<b>HFT</b>	<b>CHN</b>	<b>Hefei</b>
Sample product shipping label (not actual product label)			
			
<b>Product Affected:</b>			
SN74HC04DR	SN74HC08DR	SN74HC125DR	SN74HC32DR
SN74HC14DR	SN74HC74DR		

### Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: TPS2065DDBVR	QBS Package Reference: TPS2065DDBVR
AC	Autoclave 121C	(96 hours)	-	3/231/0
CDM	ESD - CDM	1500V	-	1/3/0
DS	Die Shear	QSS 009-009	1/10/0	3/30/0
FLAM	Flammability (IEC 695-2-2)	(IEC 695-2-2)	-	3/15/0
FLAM	Flammability (UL 94V-0)	(UL 94V-0)	-	3/15/0
FLAM	Flammability (UL-1694)	(UL-1694)	-	3/15/0
HAST	Biased HAST, 130C/85%RH	(96 hours)	-	3/231/0
HTOL	Life Test, 125C	(1000 hours)	-	1/77/0
HTSL	High Temp Storage Bake 170C	(170C / 420Hrs)	-	3/231/0
LI	Lead Fatigue	N/A	-	3/66/0
MQ	Manufacturability (Assembly)	(Approved by AT Site)	-	3/Pass
PD	Physical Dimensions	(per mechanical drawing)	-	3/15/0
PKG	Lead Finish Adhesion	N/A/-	-	3/45/0
TC	Temperature Cycle, -65/150C	(500 cycles)	-	3/231/0
WBP	Bond Pull	76 Wires, 3 units min	1/76/0	3/228/0
WBS	Ball Bond Shear	76 balls, 3 units min	1/76/0	3/228/0

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- QBS: Qual By Similarity

- Qual Device TPS2065DDBVR is qualified at LEVEL2-260CG

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JEDEC JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

#### Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

## Qualification Results

**Data Displayed as: Number of lots / Total sample size / Total failed**

Type:		ED	CDM	HBM	LU
Test Name / Condition:		Electrical Characterization	ESD - CDM	ESD - HBM	Latch-up
Duration:		Per Datasheet Parameters)	1000V	2000V	(Per AEC Q100-004)
Qual Device:	<a href="#">CD74HC00M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC02M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC04M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC08M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC10M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC11M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC125M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC126M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC132M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC14M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC20M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC21M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC27M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC30M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC32M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC4075M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC7266M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC74M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">CD74HC86M96</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC00DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC00DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC02DR</a>	Pass	1/3/0	1/3/0	1/6/0

Qual Device:	<a href="#">SN74HC02DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC03DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC04DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC04DRG3</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC04DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC08DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC08DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC10DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC11DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC125DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC125DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC126DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC132DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC14DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC14DRG3</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC14DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC20DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC21DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC266DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC27DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC32DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC32DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC7001DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC7002DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC74DR</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC74DRG4</a>	Pass	1/3/0	1/3/0	1/6/0
Qual Device:	<a href="#">SN74HC86DR</a>	Pass	1/3/0	1/3/0	1/6/0

- QBS: Qual By Similarity

- Qual Devices are qualified at LEVEL1-260CG

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	<a href="mailto:PCNAmericasContact@list.ti.com">PCNAmericasContact@list.ti.com</a>
Europe	<a href="mailto:PCNEuropeContact@list.ti.com">PCNEuropeContact@list.ti.com</a>
Asia Pacific	<a href="mailto:PCNAsiaContact@list.ti.com">PCNAsiaContact@list.ti.com</a>
WW PCN Team	<a href="mailto:PCN_ww_admin_team@list.ti.com">PCN_ww_admin_team@list.ti.com</a>

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